

Notice of References Cited

Application/Control No.

10/056,343

Applicant(s)/Patent Under
Reexamination
BHATTACHARYA ET AL.

Examiner

Phallaka Kik

Art Unit

2825

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,523,156	02-2003	Cirit, Mehmet A.	716/9
	B	US-6,490,708	12-2002	Cohn et al.	716/4
	C	US-2002/0083398	06-2002	Takeyama et al.	716/1
	D	US-5,586,046	12-1996	Feldbaumer et al.	716/18
	E	US-5,459,673	10-1995	Carmean et al.	716/6
	F	US-5,416,718	05-1995	Yamazaki, Masami	716/5
	G	US-6,190,433	02-2001	Van Fleet et al.	71/18
	H	US-6,536,018	03-2003	Chisholm et al.	716/4
	I	US-6,519,609	02-2003	Touzet, Olivier	707/104.1
	J	US-6,470,486	10-2002	Knapp, David	716/18
	K	US-6,086,626	07-2000	Jain et al.	716/5
	L	US-5,764,525	06-1998	Mahmood et al.	716/18
	M	US-5,726,903	03-1998	Kerzman et al.	716/2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200142994 A2	06-2001	World Intellect	REGAN, T J	G06F 17/50
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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